23.	In a transistor amplifier, $\beta = 62$, $R_L = 5000 \Omega$	33.	The α_{dc} c
	and internal resistance of the transistor is 500_{Ω} .		1)>1
	The voltage amplification of the amplifier will be	34	The B of
	1) 500 2) 620 3) 780 4) 950		common
24.	In a transistor amplifier $\beta = 62$, $R_1 = 5000 \Omega$		rent is 5m
	and internal resistance of the transistor is $500 \mathrm{O}$.		1) $0.45m$
	Its power amplification will be		3) 370 m
	1) 25580 2) 33760	35.	If a chang
	3) 38440 4) 55760		n-n-n tran
25.	A transistor having $\alpha = 0.99$ is used in common		collector of
	base amplifier. If the load resistance is 4.5K_{Ω}		sistor is
	and the dynamic resistance of the emitter junction		1) 10
	is 50 Ω , the voltage gain of the amplifier will be	36.	The colle
	1) 7910 2) 8910 3) 9910 4) 6910		2.9mA
26.	For a transistor the current amplification factor		transistor
	is 0.8. The transistor is connected in common		1) 0.06
	emitter configuration, the change in collector cur-	37	1) 0.00
	rent when the base current changes by 6mA is	57.	rent chon
	1) 6mA 2) 4.8mA 3) 24mA 4) 8mA		changed b
27.	In a transistor circuit, when the base current is		voltage T
	increased by 50 μ A, keeping collector voltage		$1)40^{\circ}$
	fixed at 2 volt, the collector current increases by	38	$For a p_{-}p_{-}$
	1.0mA. The current amplification factor of the	50.	emitter ci
	transistor will be		base curre
	1) 10 2) 20 3) 30 4) 40		1) $0.95 \mathrm{m}$
28.	The value of α of a transistor is 0.9. What would		3) 9.5mA
	be the change in the collector current correspond-	39.	In a n-p-n
	ing to a change of 4mA in the base current in a		ter in 10 ⁻⁶ s
	common emitter arrangement		base, the
	1) 36mA 2) 72mA 3) 18mA 4) 54mA		amplificat
29.	In a common base circuit, if the collector base volt-		1) 0.98, 4
	age is changed by 0.6V, collector current changes		3) 0.98, 9
	by 0.02mA. The output resistance will be	40.	If the coll
	1) $10^{4}\Omega$ 2) 2 x $10^{4}\Omega$		3mA in a t
	3) $3 \times 10^4 \Omega$ 4) $4 \times 10^4 \Omega$		age is inci
30.	For a common base amplifier, the values of re-		sistance is
	sistance gain and voltage gain are 3000 and 2800		1) 1KΩ
	respectively. The current gain will be	41.	A change
	1) 0.93 2) 0.83 3) 0.73 4) 0.63		causes a c
31.	For a CB amplifier current gain is 54. If the emitter		The input
	current is 6.8mA, the base current will be		1) $2K_{\Omega}$
	1) 0.486mA 2) 0.239mA		$3)2m_{\Omega}$
	3) 0.123mA 4) 0.68mA	42.	The char
32.	In a given transistor, the emitter current is		character
	changed by 2.1 mA. This results in a change of		factor β
	2 IIIA in the collector current and a change of		current a
	1.05 v in the emitter base voltage. The imput re-		1)0.1m/
	$\frac{1}{5} \frac{5}{4} \frac{1}{2} \frac{1}$		3) 0.01 m
	1) JK(2) = 2j JK(2) J IK(2) 4 U JK(2)		- ,

3. The α_{dc} of a transister is always 1) > 1 2) < 1 3) = 0 4) Negative

- 34. The β of a transistor is 74. It is connected in common base configuration. If the emitter current is 5mA, the collector current is
 1) 0.45mA
 2) 4.93 mA
 3) 370 mA
 4) 5mA
- 35. If a change of $100 \ \mu$ A in the base current of an n-p-n transistor causes a change of 10mA in the collector current, the ac current gain of the transistor is

36. The collector current in a transistor circuit is 2.9mA. If base current is $100\mu A \cdot \alpha$ of t;he transistor is

0.06 2) 0.77 3) 0.97 4) 0.87

37. In a common base configuration the emitter current changes by 5mA when emitter voltage is changed by 200mA at a fixed collector to base voltage. The input resistance is

1)
$$40_{\Omega}$$
 2) 1000_{Ω} 3) 2.5_{Ω} 4) 4_{Ω}

- 38. For a p-n-p transistor in CB configuration, the emitter current I_E is 1mA and $\alpha = 0.95$. The base current and collector current are 1) 0.95 mA, 0.05mA 2) 0.05mA, 0.95mA 3) 9.5mA, 0.5mA 4) 0.5mA, 9.5mA
- 39. In a n-p-n transistor 10¹⁰ electron enter the emitter in 10⁻⁶s. If 2% of the electrons are lost in the base, the current transfer ratio and the current amplification factor are

40. If the collector current changes from 2mA to 3mA in a transistor when collector - emitter voltage is increased from 2V to 10V, the output resistance is

1) $1K_{\Omega}$ 2) $8K_{\Omega}$ 3) $8m_{\Omega}$ 4) $1K_{\Omega}$

- 41. A change of 200mV in base-emitter voltage causes a change of $100 \ \mu$ A in the base current. The input resistance of the transistor is
 - $2K_{\Omega}$ 2) 2_{Ω}
 - $3) 2m_{\Omega} \qquad \qquad 4) 10K_{\Omega}$
- 42. The change in base current from transistor characteristics when current amplification factor $\beta = 100$, with change in collector current as 1mA 1) 0.1mA 2) 1mA

J.IIIIA	2) I IIIA
0.01mA	4) 0.001mA

43.	For a common emitter amplifier, current gain is		1) 1.952 2) 19.52 3) 195.2 4) 1952
	70. If the emitter current is 8.8mA, then the col-	54	. In the above problem α of the transistor is
	lector current is		1) 0.952 2) 9.51
	1) 0.124mA 2) 4.34mA		3) 95.1 4) 0.0951
	3) 8.68 mA 4) 1.72mA	55	. A change of 200mV in base-emitter voltage
44.	For a common emitter amplifier, current gain is		causes a change of 100μ A in the base
	70. If the emitter current is 8.4mA, then the base		current. The input resistance of the transistor
	current is		is
	1) 0.236mA 2) 0.118mA		1) $1KO$ 2) $6KO$
	3) 0.59mA 4) 8.3mA		$3) 2VO \qquad 4) 8VO$
45.	A change of 8mA in the emitter current brings	56	(-7) (-7) (-7) (-7) (-7) (-7) (-7) (-7)
	a change of 7.9mA in the collector current.		10 m Λ If 10% of the electrons are lost in the base
	The change in base current is required to		then the emitter current is
	have the same change in the collector curent		$1)10mA \qquad 2)09mA$
			3)0.09mA 4)11.1mA
	1) 0.01 mA 2) 1A	57	Ear a transistor the value of α is 0.0. Its β
10	5) 10mA 4) 0.1mA		. For a transition the value of α is 0.9. Its β
40.	In the above problem value of α is 1) 80/70 2) 70/80		
	1)00/19 2)19/80 2)70 4)90		1) 9 2) 0.9 3) 0.09 4) 90
	5) / 9 4) 80 1 1	58	. A transistor with β value equal to 80 has a
47.	In problem number 45, the value of β is		change of 250μ A in base current. Then the
	1) 79/80 2) 80/79		change in collector current is
	3) 79 4) 80		1) $2 \mu A$ 2) 20mA 3) 2mA 4) 20 μA
48.	For a common emitter amplifier, current gain is	59	. The barrier potential in a p-n junction is 0.3V
	60. If the emitter current is 6.6mA the collector		The current required is 6mA. The emf of the cel
			required for use in the circuit if a resistance of
	1) 0.108mA 2) 6.492mA		200 Ω is connected in series with junction
40	5) 1.1mA 4) 3.3mA In the charge much 1 (1, 1)		1) 3 V 2) 2 V 3) 1.5 V 4) 5 V
49.	In the above problem, the base current is $1 + 1 + 0 = 0$		
	$\begin{array}{cccccccccccccccccccccccccccccccccccc$		EXTRA BITS LEVEL-I
50	JU.100111A 4) 8.01MA	60) The electrical conductivity of a semi conduc-
50.	of the output circuit is 1000 times the load resis		tor increases when electromagnetic radiation
	tance of the input circuit If $\alpha = 0.08$ the volt		of wavelength shorter than 2480 nm is
	and of the input of cut. If $\alpha = 0.50$, the volt-		incident on it. The forbidden band energy for
	1) 98000 2) 40000 3) 0800 4) 4000		the semi conductor is (in eV)
51	In a common emitter amplifier the load resistance		1) 0.5 2) 0.9 3) 0.7 4) 1.1
51.	of the output circuit is 800 times the load resis-	61) In the given diagram, the input is given across
	tance of the input circuit If $\alpha = 0.99$ the volt-		the terminals A and C and the output is taken
	are gain is		across the terminals B and D. Then the output
	1) 79200 2) 39600 3) 7920 4) 3960		is
52.	In a silicon transistor, a change of 7.89mA in		В
	the emitter current, produces a change of		\sim
	7.8mA in the collector current. The change in		
	the base current is necessary to produce an		
	equivalent change in the collector current		XX XX
	1)90mA 2)90A		Ď
	3) 90 µ A 4) 0.9mA		1) Zaro 2) Some as input
53.	The base current of a transistor is 105 μ A and		3) Full wave rectified
	the collector current is $2.05 \text{m} \Delta$ Then <i>B</i> of the		4) Half-wave rectified
	transistor is		



LEVEL-II

1. Two similar p-n junctions can be connected in three different ways as shown in the figures. The two connections across which the potential difference is same are



2. A cell of emf 4.5V is connected to a junction diode whose barrier potential is 0.7V. If the external resistance in the circuit is 190_{Ω} , the current in the circuit is 1) 20 mA 2)2mA 4) 200mA 3)23mA 3. Which of the following circuit diagram correctly represent the direction of flow of charge carriers in the farward bias of p-n junction 3) The current through a ideal P-N junction shown 4. in the following circuit diagram will be 700Ω ·2V 3) 70 mA 4)100 mA 1)5 mA2) 10 mA 5. From the adjecent circuit, the output voltage is 15KΩ 100 V10 V 1) 10 V 2) 100 V 3) 90 V 4) zero From the circuit shown below, the maximum and 6. minimum values of zener diode current are



7.



SEMI CONDUCTOR DEVICES

3) 4 μ A 4) 40 μ A

4) 0.04A

4) 2

8) 3

12)1

150 Ω

50 Q

3)3

7)1

11)1

 100Ω

50.	voltage amplification $\ll = \beta \times \frac{R_L}{R_i}$	03.	1) a & b 2) a & c 3) b & c 4) all In a p-n junction a) The diffusion current is from n- side to p-
	but $\beta = \frac{\alpha}{1 - \alpha} \Longrightarrow \beta = 49$ $\frac{R_{L}}{R} = 1000$		side b) The diffusion current p-side to n-side c) The drift current is from n-side to p-side d) the drift current from p-side to n-side
5. 52.	K_i same as 50 $\Delta I_b = \Delta I_E - \Delta I_C$	04.	1) a & b 2) b & c 3) a,b & c 4) all Leakage current in a juction diode a) increases with temperature b) is due to minority carries
53	$\beta = \frac{I_c}{I_b}$		c) depends on method of its fabricationd) is in the range of μA (or) $_{nA}$ 1) a, b & d 2) a & b 3) a & c 4) all
54.	$\beta = \frac{\alpha}{1 - \alpha}$	5)	In a $p-n$ junction a) drift current is influenced by concentration gradient of carriers.
55.	$\beta = \frac{\alpha}{1 - \alpha} \text{ find } \beta$ $\beta \times I_{B} = I_{C}$		b) diffusion current is influenced by concentration gradient of carriers.c) drift is influenced by magnitude of applied
56.	$I_{\rm B} = 10 \times 10^{-3} - \frac{10}{100} \times 10^{-3} = 1 \times 10^{-3} \mathrm{amp}$		voltage d) diffusion is influenced by magnitude of applied voltage,
53.	$\beta = \frac{\Delta I_c}{\Delta I_b}$	6)	1) a & b 2) b & c 3) a, b & c 4) all In a $p - n$ junction with no applied voltage a) There is a net charge transfer between the two
52	Diode resistance $\ll \frac{0.3}{6\text{mA}} = 50\Omega$		sides b) There is no net charge transfer between the two sides
	$\therefore \text{ cell voltage } \ll (6\text{mA}) \times (200 + 50)$ NEW MODEL OUESTIONS		c) There is no electric field near the junctiond) There is a constant electric field near the impatien
Stat	ement Type		$\begin{array}{c} \text{Junction} \\ 1 \end{pmatrix} a \& b \\ 2 \end{pmatrix} b \& c \\ 3 \end{pmatrix} b \& d \\ 4 \end{pmatrix} all$
01.	The current through any p-n junction is due to a) drift of charge carriers b) diffusion of charge carriers c) different concentrations of same type of charge	07.	Diode is forward biased and the applied voltage is greater than the potential barrier then I) Resistance of the junction in the forward bias decreases
	carriers in different regions d) same concentrations of same type of charge carriers in different regions		II) Potential barrier remains same III) Width of the depletion layer decreases IV) p-type is at higher potential than the n-type
02.	3) only d 4) all when a p-n junction is formed ,then	08.	1. All are true2. All are false3. I, III, IV are true4. I, II, III are trueI) The current in a diode is directly proportional
	a) immediately, there is a diffusion of charge carriers across the junctionb) immediately, there is no diffusion of charge		to the applied voltage II) During amplification frequency of the signal is increased
	 carriers across the junction c) diffusion of charge carriers is due to thermal agitation d) diffusion of charge carriers is due to potential barrier across the junction 		1. Both are true2. both are false3. I is true4. II is true
		21	

9.	Match the following	
	a. Antimony	e. P - type
	b. Indium	f. N - type
	c. Carbon	g. not semiconductor
	d. Silicon	h. semiconductor
	1. a - f, b - e, c - g, d - 2 - 1 - 1	h C
	2.a - e, b - g, c - n, d - 3 - g, b - h, c - f, d - 3	
	4. a - h, b - f, c - e, d - d	g
10.	Match the following	0
	LIST - I	LIST - II
	a. <i>h</i> _{fe}	e. $\left(\frac{\Delta V_{BE}}{\Delta I_b}\right)_{V_{CE}}$
	b. <i>h</i> _{ie}	$f.\left(\frac{\Delta I_C}{\Delta V_{CE}}\right)_{I_b}$
	c. <i>h</i> _{re}	$\mathbf{g} \cdot \left(\frac{\Delta I_C}{\Delta I_b}\right)_{V_{CE}}$
	d. <i>h</i> _{oe}	h. $\left(\frac{\Delta V_{BE}}{\Delta I_{CE}}\right)_{I_b}$
	1.a - g, b - e, c - h, d - 2.a - b - b - c - f - d	t ~
	2.a - e, b - n, c - 1, d - 3 a - h h - f c - g d - 1	g
	4. a - f. b - g. c - e. d - d	h
11.	Match the following	
	LIST - I	LIST - II
	a. Transistor	e. in filter circuit
	b. Diode	f. voltage regulator
	d. Capacitor	g. switch h. modulator
	1. a - h, b - g, c - f, d -	e
	2. a - g, b - f, c - e, d -	h
	3. a - f, b - e, c - h, d -	g
12	4. a - e, b - h, c - g, d - Match the following	Ι
12.	LIST - I	LIST - II
	a. Current gain	e. $\frac{\Delta I_c}{\Delta I_b}$
	b. Voltage gain	f. $\frac{\Delta I_c}{\Delta I_b} \frac{R_L}{R_i}$
	c. Power gain	g. $\left(\frac{\Delta I_c}{\Delta I_b}\right)^2 \frac{R_L}{R_i}$

d. Resistance gain

- $\frac{R_L}{R_i}$
- 1. a e, b f, c g, d h 2. a - f, b - g, c - h, d - e 3. a - g, b - h, c - e, d - f 4. a - h, b - e, c - f, d - g

ASSERTION AND REASON TYPE

In each of the following questions, a statement of Assertion (A) is given followed by a corresponding statement of Reason (R) just below it. Of the statements, mark the correct answer.

 If both Assertion and Reason are true and Reason is the correct explanation of Assertion.
 If both Assertion and Reason are true but Reason is not the correct explanation of Assertion.

3. If assertion is true but Reason is false.

- 4. If assertion and reason are false
- 13. (A): Holes cannot be considered as antiparticles of electrons

(R): Electron is a material particle but not a hole

 14. (A): The potential difference across an unbiased P-N junction cannot be measured by connecting voltmeters across its terminals.

(R) : There are no free charge carriers in the depletion zone. Voltmeter requires current to indicate potential difference.

- 15. (A): Germanium is more preferred to the silicon.(R): Forbidden energy gap is less in germanium.
- 16. (A): The silicon diode conducts current when the battery voltage is greater than 0.7V.
 (R): Barrier potential of the silicon is 0.3V.
 17. (A): Diode is unidirectional.

(R): It allows the current in the forward bias when the applied voltage is greater than the barrier potential.

- 18. (A): All the intrinsic semiconductors are insulators at absolute zero temperature.(R): All electrons are tightly bound at absolute zero temperature.
- 19. (A): The resistance of instrinsic semiconductor decreases with increase of temperature.(R): Mobile electrons are present in valence band.

00		, 1.44	4	
20.	(A): Both N-type and P- type are electrically		4.	In n-p-n transistor, in CE configuration :(2004E)
	neutral			(a) The emitter is heavily doped than the collector
	(R): Neutral atoms are added during doping			(b) Emitter and collector can be interchanged
21.	(A): When a donor electron is excited to the			(c) The base region is very thin but is heavily
	conduction band no hole	is created		doped
	(R) : Donor energy level	l does not exist in the		(d) The conventional current flows from base to
	valence band			emitter
22.	(A): Holes are positievly	charged particles.		1. (a) and (b) are correct
	(R): Holes are the vacanie	es for the positive ions		2. (a) and (c) are correct
	to form the covalent bonds.			3. (a) and (d) are correct
				4. (b) and (c) are correct
	KEY FOR NEW	MODEL	5.	Consider the following statements A and B and
	OUEST	IONS		identify the correct answer : (2003M)
	1) 1 2) 2	(3) 2 (4) 1		(A) A Zener diode is always connected in reverse
	1)1 2)2	5)2 4)1		bias.
	5) 2 6) 3	7) 3 8) 2		(B) The potential barrier of a p - n junction lies
	9) 1 10) 1	11)1 12)1		between 0.1 to $0.3V$, approximately
	13) 1 14) 1	15) 1 16) 3		1. A and B are correct 2. A and B are wrong
	17) 1 18) 1	19) 2 20) 1		3. A is correct but B is wrong
	(1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1	1)2 20)1		4. A is wrong but B is correct
	21)1 22)4		6.	When $n - p - n$ transistor is used as an amplifier: (2003 E)
οι	JESTIONS FROM PRE	VIOUS EAMCET		1. electrons move from base to collector
	EXAN	MS		2. holes moves from emitter to base
1.	An n-pn transistor power	amplifier in C-E		3. holes move from collector to base
	configuration gives	(2005 E)		4. holes move from base to emitter
	1) Voltage amplification of	nly	7.	In a transistor circuit, when the base curent is
	2) Current amplification o	nly		increased by 50micro-amperes keeping the col-
	3) Both current and voltage	ge amplification		lector voltage fixed at 2 volts, the collector curent
	4) Only power gain of uni	ity		increases by 1mA. The current gain of the tran-
2.	Consider the following st	atements A and B and		sistor is (2002E)
	identify the correct answe	er (2005M)		1) 20 2) 40 3) 60 4) 80
	A): Germanium is prefer	red over silicon in the	8.	A common emitter transistor amplifier has a cur-
	construction of zener dioc	le.		rent gain of 50. If the load resistance is $4k \Omega$,
	B): Germanium has high t	thermal stability than		and input resistance is 500 O the voltage gain
	silicon in the construction	of Zener diode		of amplifier is (2002E)
	1) Both (A) and (B) are the function (A) and (B) are the function (A) and (A) are the function (A) are the function (A) and (A) are the function (A) and (A) are the function (A) are the functio	rue		$\begin{array}{c} (2002L) \\ (2002L) \\$
	2) Both (A) and (B) are factorial and (B) ar	alse	9	The current gain of transistor in a common emit.
	3) (A) is true but (b) is fall (A)	se		ter circuit is 40. The ratio of emitter current to
	4) (A) is false but (B) is the (A)	rue		base current is (2002M)
3.	A Zener diode when used	as a voltage regulator		$\begin{array}{c} 1) 40 \\ 2) 41 \\ 3) 42 \\ 4) 43 \\ \end{array}$
	is connected (2004 M) $()$	(1)' 1'	10.	The reverse voltage ratio of emitter transistor cir-
	(a) in forward bias (a) in normality (a) (a)	(b) in reverse bias (1) in reverse (1)		cuit is represented as (2002M)
	(c) in parallel to the load 1	(u) in series to the load		
	1. (a) and (b) are correct 2. (b) and (c) are correct			$1) \left[\frac{\Delta V_{be}}{\Delta V_{be}} \right] \qquad \qquad 2) \left[\frac{\Delta V_{be}}{\Delta V_{be}} \right]$
	2. (b) and (c) are correct 3. (a) only is correct			$(\Delta V_{ce})_{I_b} \qquad (\Delta I_b)_{V_{ce}}$
	4 (d) only is correct			
	4. (d) only is contect			$(\Delta I_c) \left(\Delta V_{ce} \right) $
				$J \left(\Delta I_b \right)_{V_{cc}} \qquad \qquad$

11.	While a collector emitter voltage is constant in a	18.	The element that can be used as acceptor
1	transistor, the collector current changes by 8.2mA		impurity to dop silion is (1999)
	when the emitter current changes by 8.3mA. The		1)Antimony 2)Arsenic
	value of forward curent ratio h_{fe} is (2001E)		3) Boron 4) phosphorous
	1) 82 2) 83 3) 8.2 4) 8.3	19.	In case of semiconductor which one of the
12.	The current gain (β) of a transistor in common		following statement is wrong? (1998)
	emitter mode is 40. To change the collector cur-		1) Resistivity is in between that of a conductor
	rent by 160mA, the necessary change in the base		and insulator
	current is (at constant V) (2001)		2) Temperature coefficient of resistance is
	1) 0.25μ A 2) 4μ A		negative
	3) $4mA$ 4) $40mA$		3) doping increases conductivity
13.	Consider the following statements A and B iden-		4) At absolute zero temperature it behaves like
	tify the correct of the give answer. (2000)		a conductor
	A) The width of the depletion layer in a p-n	20.	The potential in the depeltion layer due to
	juction diode increases in forward biads.		(1998)
	B) In an intrinsic semiconductor the fermi		1) Electrons 2) Holes
	energy level is exactly in the middle of the		3)Ions 4) Forbidden band
	forbidden gap	21.	A hole is (1998)
	1) A is true and B is false		1) A positively charged electron
	2) Both A and B are false		2) An electron in the valence band
	3) A is false and B is true		3) an unfulfilled covalent band
	4) Both A and B are true		4) an excess electron in covalent bond
14	An n-type and p-type silicon can be obtained	22.	The value indicated by fermi energy level in an
	by doping pure silicon with (2000)		intrinsic semiconductor is (1997)
	1) Arsenic and phosphrous		1) The average energy of electrons and holes
	2) Indium and aluminium		2) the energy of electrons in conduction band
	3) Phosphorous and indium		4) The energy of holes in valence band
	4) aluminium and boron	22	4) The energy of forbieen region The conduction hand and valency hand of a good
15.	The width of forbidden gap in silicon crustal is	23.	conductor (1006)
	1.1 ev. when the crystal is converted into a n-		1) A re well separated 2) They just touch
	type semiconductor the distance of fermi level		3) Are very close 4) They overlap
	from conduction band is (1999)	24.	Pickout the incorrect statement regarding re-
	1) Greater than 0.55eV		verse saturation current in the p-n junction diode
	2) Equal to 0.55 eV		(1996)
	3) lesser than 0.55eV		1) this current doubles for every 100°C rise of
1.0	4) Equal to 1.1 eV The first state 1116 state 12		temperature
10.	I he donor impurity to be added for doping		2) This current is due to minority carriers
	germanium crystal, will be valency (1999)		3) the current carrries are produced by thermal
17	1)2 $2)3$ $3)4$ $4)3In particular (1000)$		agitation
1/.	1) The conduction hand are values as herd		4) Reverse saturation current is also known as
1	overlan		leakage current
	2) The gap between conduction hand and	25.	Two pieces one of germinium and the other of
	2) The gap between conduction hand and valence hand is near about 16eV		aluminium are cooled from T_1K to T_2K . The re-
	3) the gap between conduction band and		sistance of (1996)
1	valence hand is near about 1eV		1) Aliminium increases and that of germanium
	4) The gap between conduction hand and		decrease
1	valence band will be 100eV and more		2) Each of them decreases
1			3) Aluminium decreases and that of germanium
1			increases
1			4) Each of the increases

26.	When the p-n junction diode is reverse is biased,	41.	In an intrinsic semiconductor, the fermi energy
	the thickness of the depletion layer (1996)		level is (1994)
	1) Increases 2) Decreases 3) Becomes zero 4) remain constant		2) Equidistant from conduction hand and valence
27	Fermi level of energy of an intrinsic semiconductor lies		band
	(1995)		3) Nearer to conduction band than valence band
	1) In the middle of the forbidden gap		4) Bisecting the conduction band
	2) Below the middle of forbidden gap	42.	A p-n junction diode is reverse biased. Then
	3) above the middle of forbidden gap		(1994)
20	4) Outside the forbidden gap		1) More current flows
28.	In a semiconductor the separation beetween con- duction hand and valence hand is of the order		2) The barrier potential decreases 3) the barrier potential increases
	(1995)		4) Resistance offered is low
	1) $100eV$ 2) $10 eV$ 3) $1 eV$ 4) $0 eV$	43.	In an intrinsic semiconducter the ratio of con-
29.	The intrinsic semiconductor behaves as insulator at		duction electrons and holes with increase
	(1995)		in temperature (1993)
	$1) 0^{\circ}C \qquad 2) 100^{\circ}C \qquad 3) 100 \text{ K} \qquad 4) 0 \text{ K}$		1) 1:1 2) 1:2 3) 2:1 4) 1:3
30.	The bond, that exists in a semiconductor is	44.	In an insulator, the energy gap between conduc-
	(1995)		tion band and valence band is about (1993)
	3) Metalic bond 4) hydrogen bond	45	If 'n' region of a semi conductor is connected to
31.	In forward bias of p-n junction, the potential barrier		negative and 'n' region to positive pole. it is said
	(1995)		to be (1993)
	1) Increases 2) Decreases		1) Directed biased 2) Unbiased
	3) Remains unchanged 4) Becomes zero		3) Forward biased 4) Reverse biased
32.	In intrinsic semiconductor at room temperature	46.	To obtain p-type extrinsic semiconductor, the
	1) Equal 2) Zero		should be valency (1903)
	3) Unequal 4) Infinite		$\begin{array}{cccc} \text{Should be valency} & (1995) \\ 1) 2 & 2) 3 & 3) 4 & 4) 5 \end{array}$
33.	Band gap in insulator is of the order (1995)	47.	A half -wave rectifier is used to convent 50Hz
	1) 6 eV 2) 0.60 eV 3) -6 eV 4) 0eV		A.C. to D.C. voltage. The number of pulses per
34.	Indium impurity in germanium makes (1995)		second in the rectified voltage are (1993)
	1) n-type 2) p-type		1) 50 2) 25 3) 100 4) 75
25	3) insulator 4) Intrinsic	48.	The majority carries in a p-type semi-conductor
55.	1) 0 eV 2) 0.7 eV 3) 1.1 eV 4) 6 eV		are (1993) 1) Electrons 2) Holes
36	p-n junction diode can be used as (1994)		3) Both 4) Impurities
0.01	1)Amplifer 2) Detector	49.	If to an intrinsic semi conductor a pentavalent
	3) Oscillator 4) Modulator		element is added as impurity, one get extrinsic
37.	When p-n junction diode is forward biased po-		semi conductor of type (1993)
	tential barrier (1994)		1) n-type 2) p-type
	1) Kemains the same 2) Increases	50	5) intrinsic 4 both 1 & 2 In an intrinsic semiconductor the charge comican
	4) may increase of decreases	50.	responsible for electrical conduction are
38.	In which of the following ionic bond is present?		(1992)
	(1994)		1) Electrons 2) Holes
	1) NaCl crystal 2) Ge		3) Impurities 4) Both 1 & 2
20	3)Ar 4)Si		$\frac{\mathbf{KEY}}{\mathbf{N}^2}$
39.	which of the following contains a covalent the tollowing contains a covalent the tollowing (1004)		$\begin{array}{cccccccccccccccccccccccccccccccccccc$
	(1994) (1994) (1994) (1994)		(0) 1 (1) 1 (2) 3 (2) (2) (2) (2) (2) (2) (2) (2) (2) (2)
40.	In p-type semiconductor conduction is due to		16)4 17)3 18)3 19)4 20)3
	(1994)		21) 3 22) 1 23) 4 24) 1 25) 3
	1) Greater number of holes and less number of		26) 1 27) 1 28) 3 29) 4 30) 1
	electrons		31) 2 32) 1 33) 1 34) 2 35) 1
	2) Only electrons 3) Only holes		36) 2 37) 3 38) 1 39) 3 40) 1 41) 2 42) 2 42) 1 44) 2 45) 1
	4) greater number of electrons and less number		41)2 $42)3$ $43)1$ $44)2$ $45)446)2$ $47)1$ $48)2$ $40)1$ $50)4$
	of notes		40/2 4//1 48/2 49/1 50/4